



US00D445703S

(12) **United States Design Patent**
Gaunt et al.

(10) **Patent No.:** **US D445,703 S**

(45) **Date of Patent:** **** Jul. 31, 2001**

(54) **QUICK SYSTEM TESTER**

OTHER PUBLICATIONS

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Sun Brochure entitled VAT45 Diagnostic Volt–Amp Tester, SS1532 rev. Oct. 15, 1998.

Snap–on Catalog #500, pp. E4 and E6.

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* cited by examiner

Primary Examiner—Antoine Duval Davis

(**) Term: **14 Years**

(74) *Attorney, Agent, or Firm*—McDermott, Will & Emery

(21) Appl. No.: **29/129,682**

(57) **CLAIM**

(22) Filed: **Sep. 21, 2000**

The ornamental design for a quick system tester, as shown and described.

(51) **LOC (7) Cl.** **10-04**

DESCRIPTION

(52) **U.S. Cl.** **D10/78**

(58) **Field of Search** D10/77; 320/132, 320/134, 136, DIG. 18, DIG. 21; 429/426, 429, 432, 433; 340/635, 636

FIG. 1 is a front perspective view of the quick system tester showing the new design;

FIG. 2 is a front plan view thereof;

FIG. 3 is a back plan view thereof;

FIG. 4 is a right side view thereof;

FIG. 5 is a left side view thereof;

FIG. 6 is a top view thereof; and,

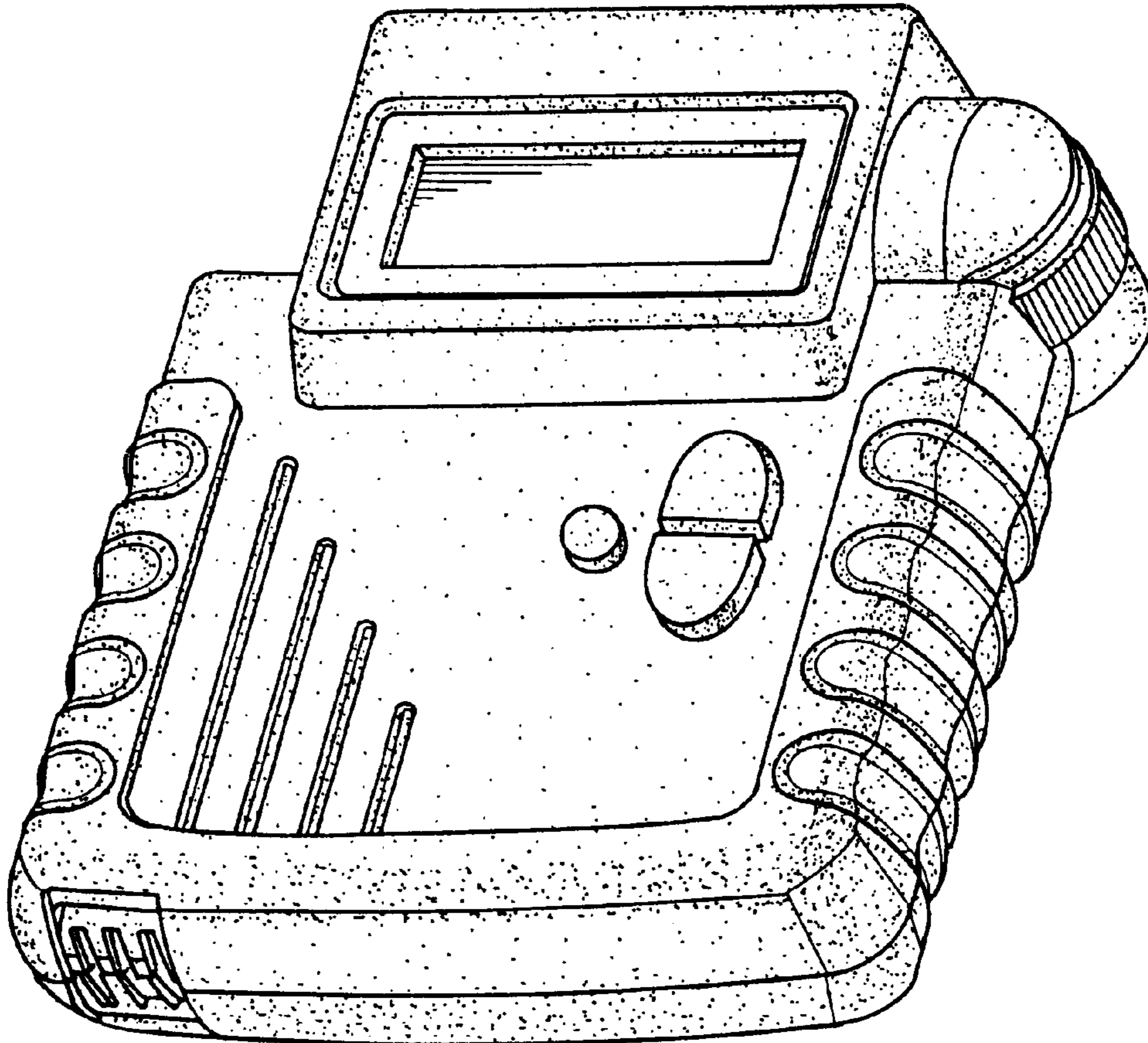
FIG. 7 is a bottom view thereof.

(56) **References Cited**

U.S. PATENT DOCUMENTS

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D. 297,516	*	9/1988	Wang	D10/77
D. 419,463	*	1/2000	Wang	D10/77
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1 Claim, 3 Drawing Sheets



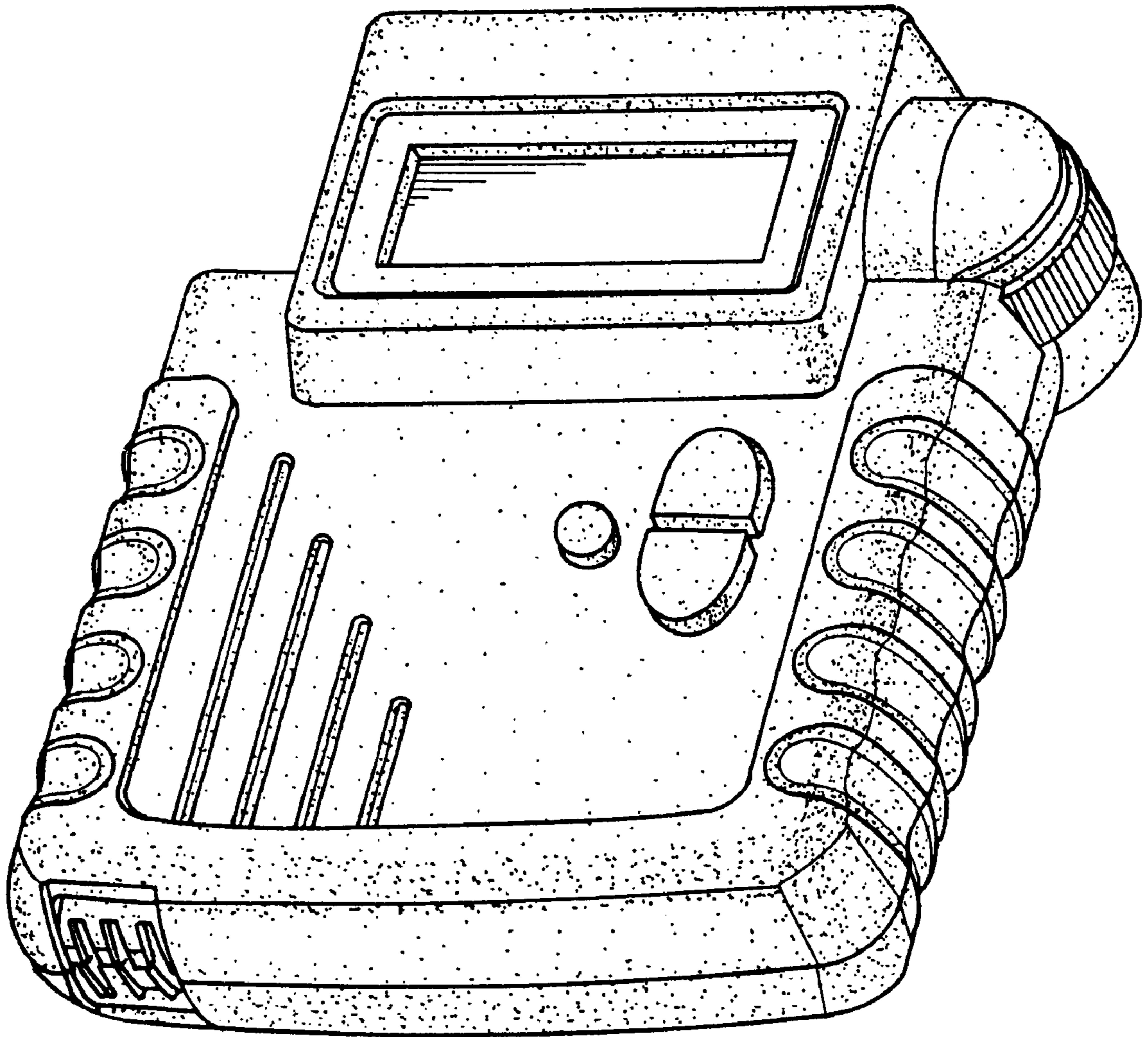


FIG. 1

FIG. 2

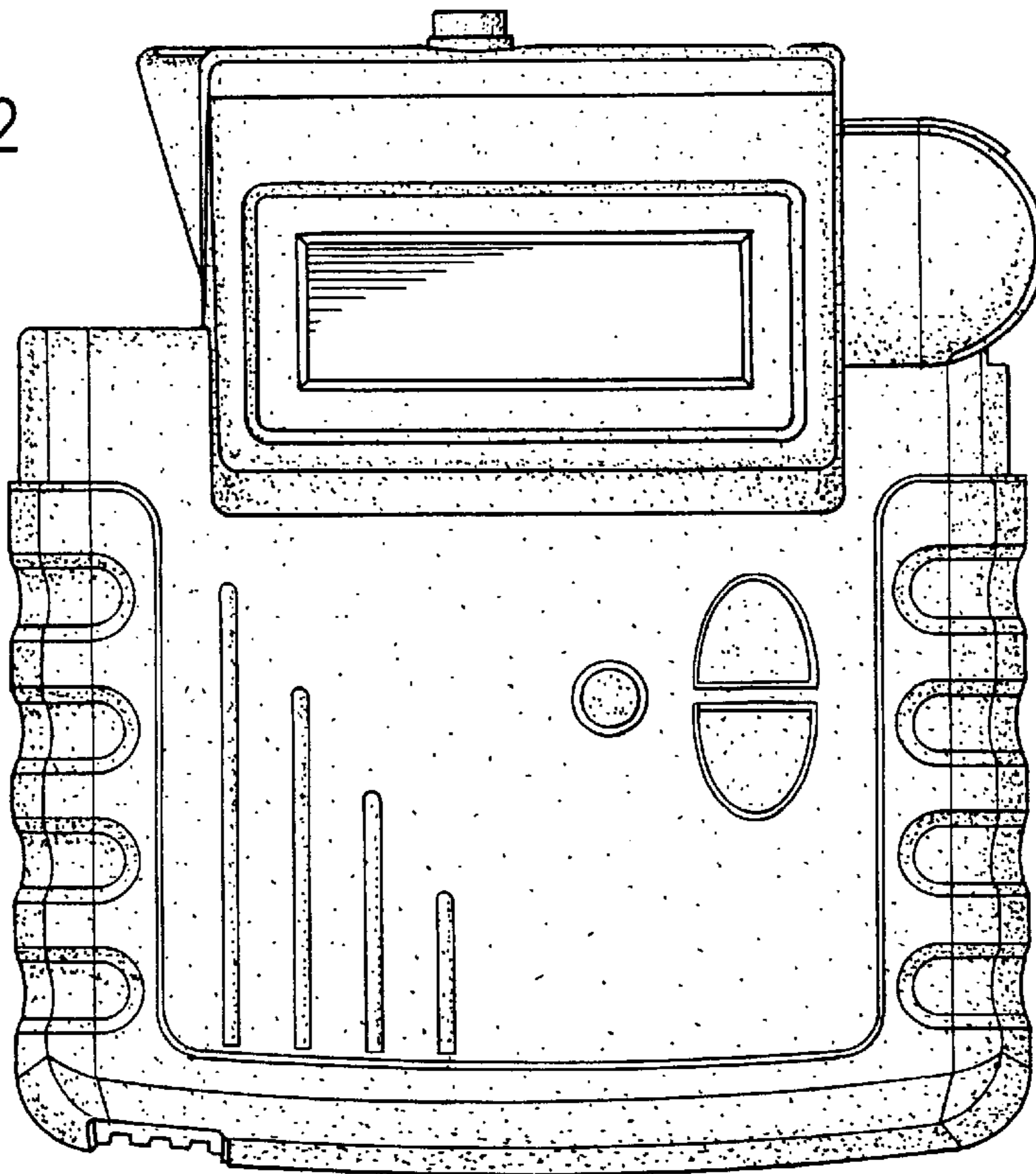


FIG. 3

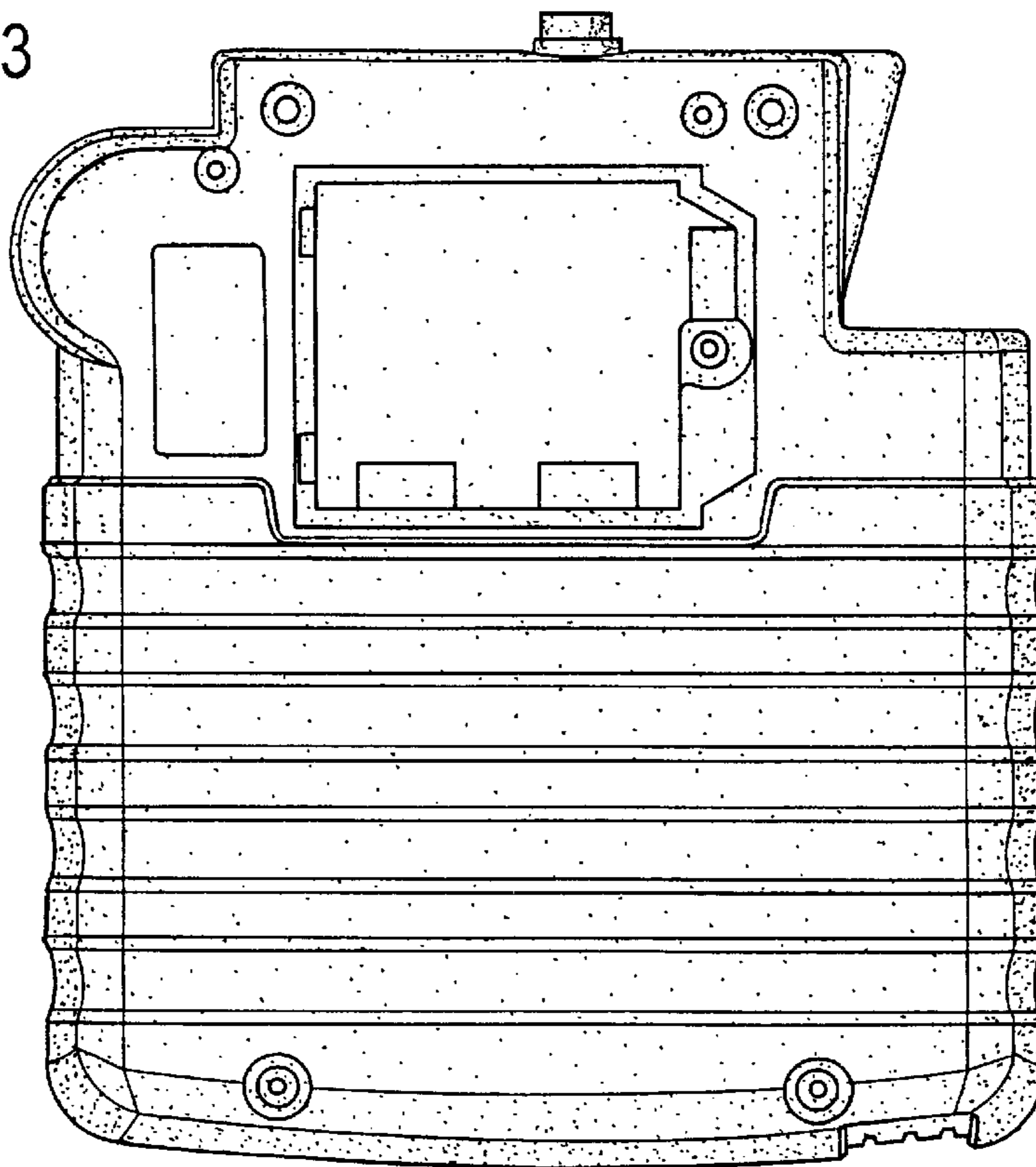


FIG. 4

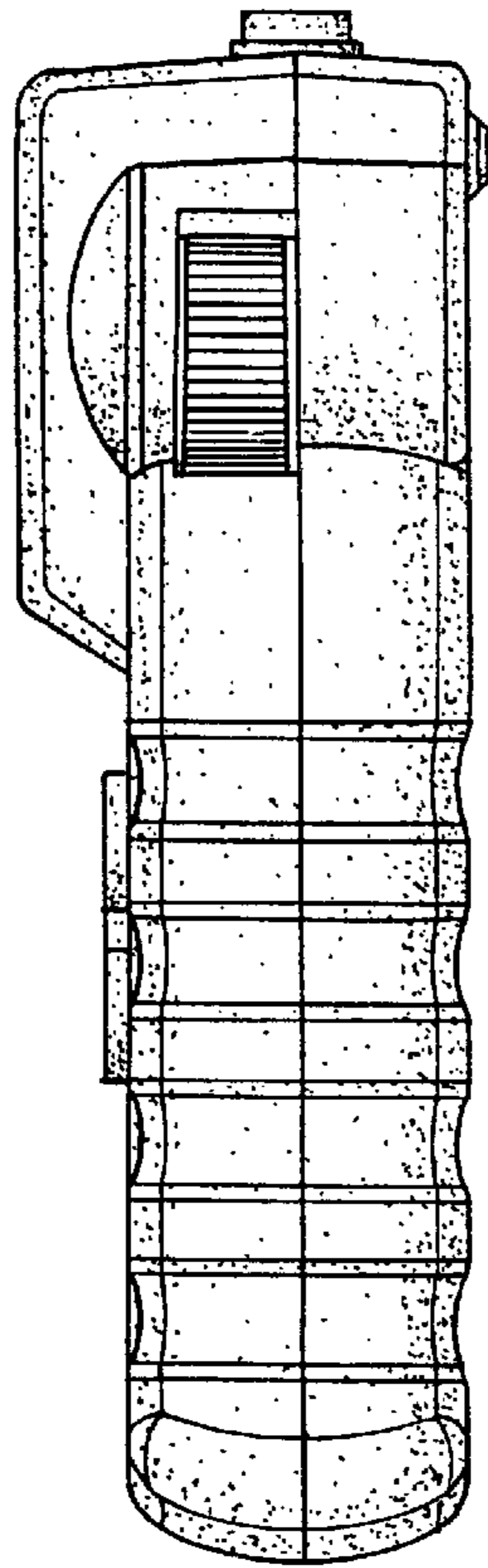


FIG. 5

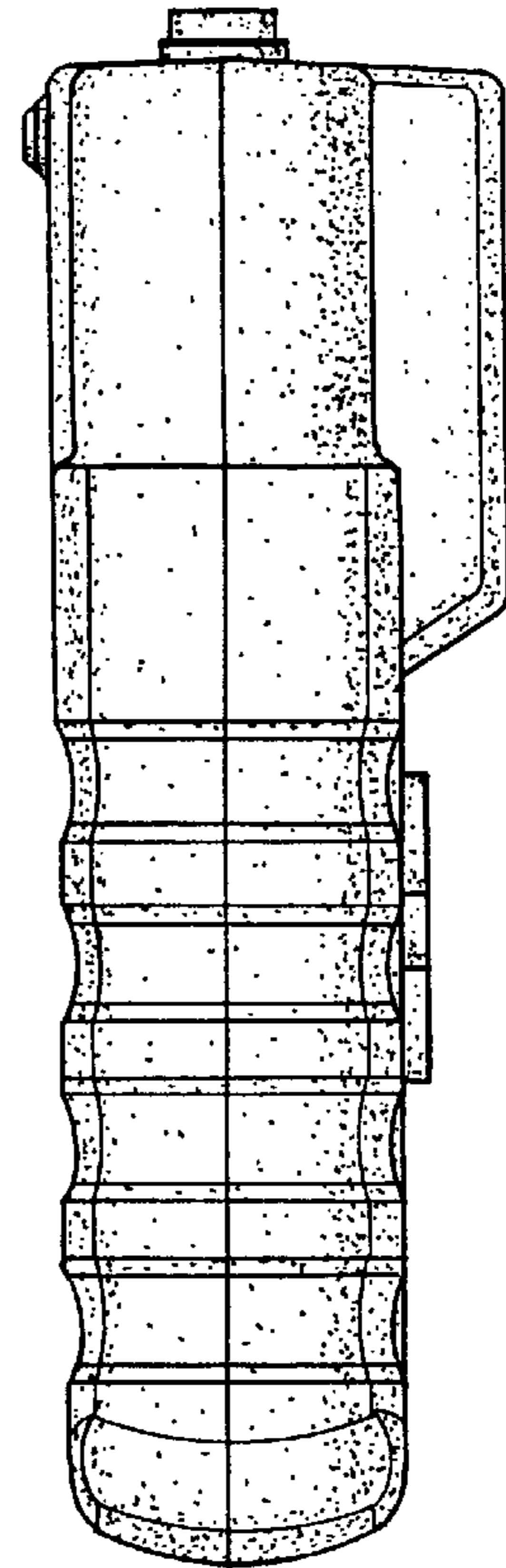


FIG. 6

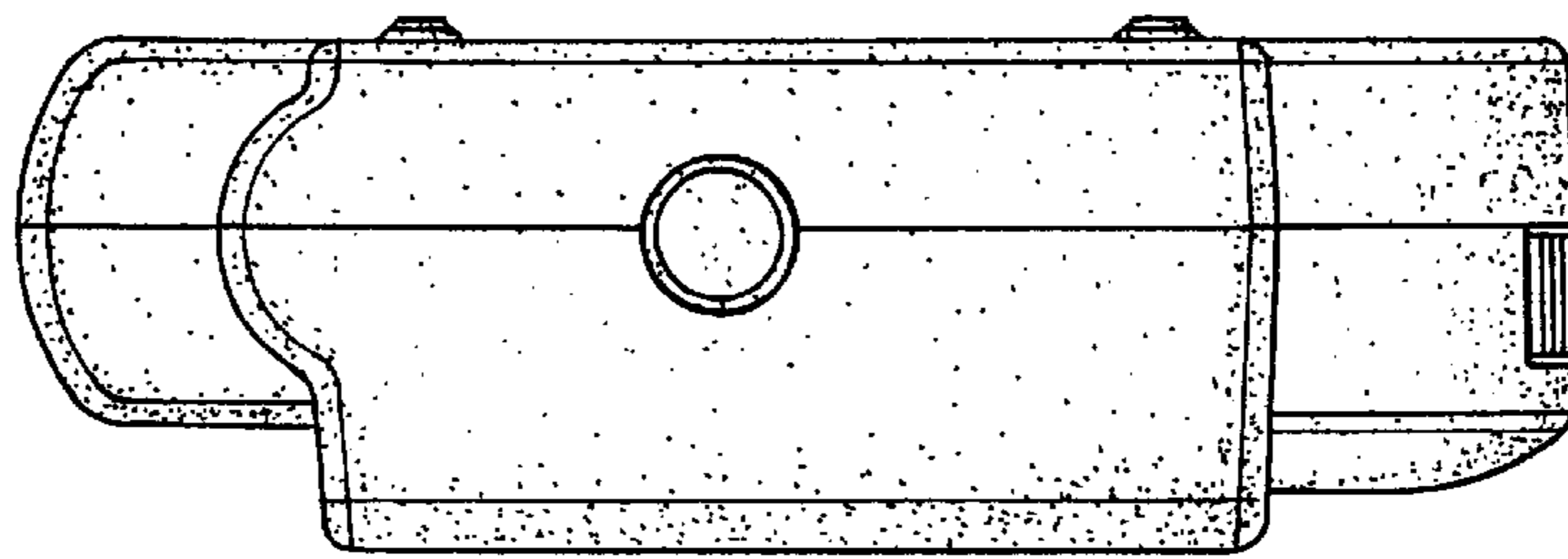


FIG. 7

